Application/Control No. Applicant(s)/Patent Under Reexamination 10/810,759 LU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Chuong A. Luu 2818 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2005/0215055 A1 09-2005 Bu et al. 438/682 Α US-6,864,178 B1 03-2005 Kim, Young Pil В 438/692 US-6,620,718 09-2003 Wieczorek et al. С 438/592 * D US-6,830,987 B1 12-2004 Pelella et al. 438/421 US-Ε US-F US-G US-Н US-1 J US-Κ US-US-L US-**FOREIGN PATENT DOCUMENTS** Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.